

# STFW6N120K3, STP6N120K3, STW6N120K3

## N-channel 1200 V, 1.95 Ωtyp., 6 A SuperMESH3™ Power MOSFET in TO-3PF, TO-220 and TO-247 packages

### Datasheet — production data

### Features

Order codes	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>	P <sub>tot</sub>
STFW6N120K3	1200 V	< 2.4 Ω	6 A	63 W
STP6N120K3	1200 V	< 2.4 Ω	6 A	150 W
STW6N120K3	1200 V	< 2.4 Ω	6 A	150 W

- 100% avalanche tested
- Extremely large avalanche performance
- Gate charge minimized
- Very low intrinsic capacitances
- Zener-protected

### **Applications**

Switching applications

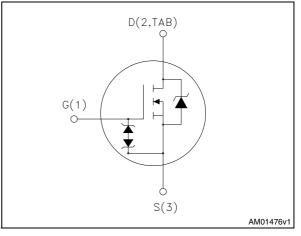
### Description

These SuperMESH3<sup>™</sup> Power MOSFETs are the result of improvements applied to STMicroelectronics' SuperMESH<sup>™</sup> technology, combined with a new optimized vertical structure. These devices boast an extremely low on-resistance, superior dynamic performance and high avalanche capability, rendering them suitable for the most demanding applications.

Table	1.	Device	summary
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TO-3PF	2 <sup>3</sup>
TAB 2 3	
TO-220	TO-247

Figure 1. Internal schematic diagram



Order codes	Marking	Package	Packaging
STFW6N120K3		TO-3PF	
STP6N120K3	6N120K3	TO-220	Tube
STW6N120K3		TO-247	

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This is information on a product in full production.

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2	Electrical characteristics
	2.1 Electrical characteristics (curves)
3	Test circuits
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# 1 Electrical ratings

Table 2.	Absolute maximum ratings				
Symbol	Parameter		Unit		
Symbol	Parameter	TO-3PF	TO-220	TO-247	Unit
V <sub>GS</sub>	Gate- source voltage		± 30		V
۱ <sub>D</sub>	Drain current (continuous) at $T_C = 25 \ ^{\circ}C$		6		А
۱ <sub>D</sub>	Drain current (continuous) at $T_C = 100 \ ^{\circ}C$		3.8		А
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	20			А
P <sub>TOT</sub>	Power dissipation at $T_C = 25 \ ^{\circ}C$	63	150	150	W
I <sub>AR</sub>	Max current during repetitive or single pulse avalanche (pulse width limited by T <sub>JMAX</sub> )	7		A	
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}, I_D = I_{AR}, V_{DD} = 50 \text{ V}$ )	180		mJ	
ESD	Gate-source human body model (C = 100 pF, R = 1.5 k $\Omega$ )	6		kV	
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s, $T_C = 25$ °C)	3500		v	
T <sub>stg</sub>	Storage temperature	-55 to 150		°C	
TJ	Operating junction temperature		-55 10 150		C

### Table 2. Absolute maximum ratings

1. Pulse width limited by safe operating area

#### Table 3.Thermal data

Symbol	Parameter		Unit		
Symbol	Falameter	TO-3PF	TO-220	TO-247	Onit
R <sub>thj-case</sub>	Thermal resistance junction-case	1.98 0.83		°C/W	
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max	50 62.5 50		°C/W	
TJ	Maximum lead temperature for soldering purpose	300		°C	



## 2 Electrical characteristics

(T<sub>C</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_{D} = 1 \text{ mA}, V_{GS} = 0$	1200	-	-	V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 1200 V V <sub>DS</sub> = 1200 V, T <sub>J</sub> = 125 °C	-	-	1 50	μΑ μΑ
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V	-	-	± 10	μA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 100 \ \mu A$	3	4	5	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.5 A	-	1.95	2.4	Ω

#### Table 4. On / off states

#### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> = 100 V, f = 1 MHz, V <sub>GS</sub> = 0	-	1050 90 1	-	pF pF pF
C <sub>o(tr)</sub> <sup>(1)</sup>	Equivalent capacitance time related	V <sub>GS</sub> = 0, V <sub>DS</sub> = 0 to 960 V	-	40	-	pF
C <sub>o(er)</sub> <sup>(2)</sup>	Equivalent capacitance energy related	$V_{GS} = 0, V_{DS} = 0$ to 960 V	-	25	-	pF
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz open drain	-	3	-	Ω
Qg	Total gate charge	V <sub>DD</sub> = 960 V, I <sub>D</sub> = 7.2 A,		39		nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 10 V	-	7.7	-	nC
Q <sub>gd</sub>	Gate-drain charge	(see <i>Figure 20</i> )		23.5		nC

1.  $C_{oss}$  eq. time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .

2.  $C_{oss}$  eq. energy related is defined as a constant equivalent capacitance giving the same stored energy as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .



	ownering times on/on					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off-delay time Fall time	$V_{DD} = 600 \text{ V}, I_D = 3.6 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 19</i> )	-	30 12 58 32	-	ns ns ns ns

Table 6.Switching times on/off

### Table 7.Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current Source-drain current (pulsed)		-	-	6 20	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 5 \text{ A}, V_{GS} = 0$	-		1.6	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}$ = 7.2 A, di/dt = 100 A/µs V <sub>DD</sub> = 60 V T <sub>J</sub> = 25 °C (see <i>Figure 24</i> )	-	580 7 25	-	ns μC Α
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 7.2 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 60 \text{ V}, \text{ T}_{J} = 150 ^{\circ}\text{C}$ (see <i>Figure 24</i> )	-	840 9 22	-	ns μC Α

1. Pulse width limited by safe operating area.

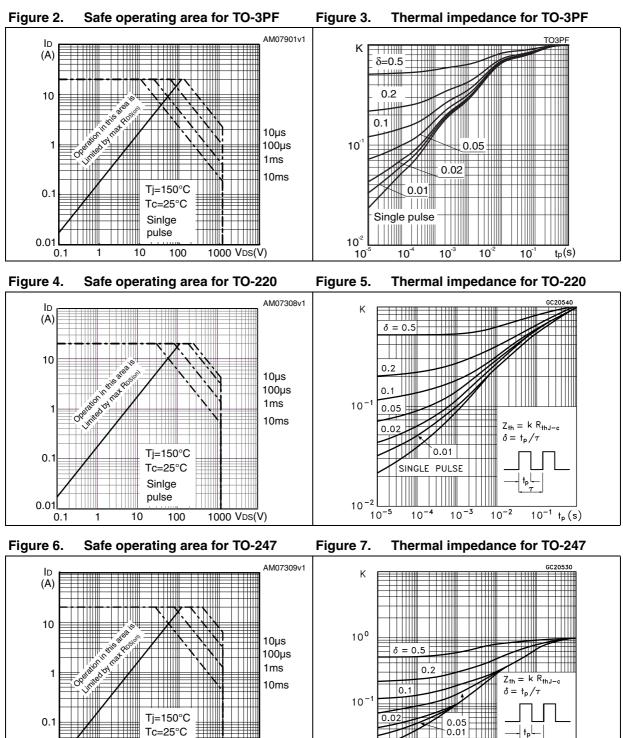
2. Pulsed: Pulse duration =  $300 \mu s$ , duty cycle 1.5%

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA} (I_D = 0)$	30	-		V

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.



### 2.1 Electrical characteristics (curves)



0.01

0.1

Sinlge pulse

100

1000 VDS(V)

10

1

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10<sup>-5</sup>

SINGLE PULSE

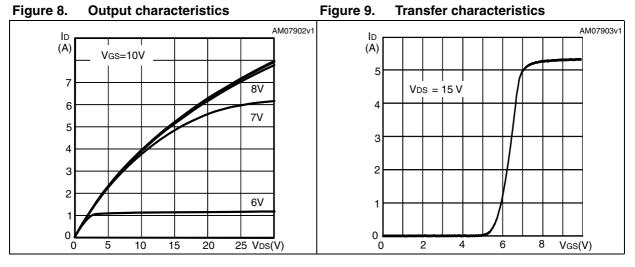
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10<sup>-2</sup>

 $10^{-1} t_{p}(s)$ 







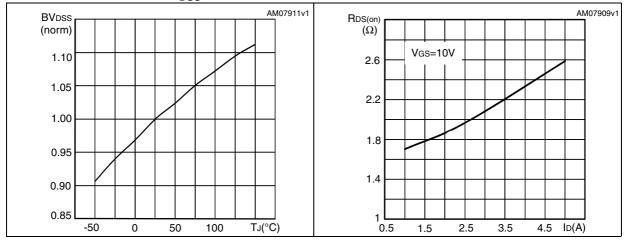
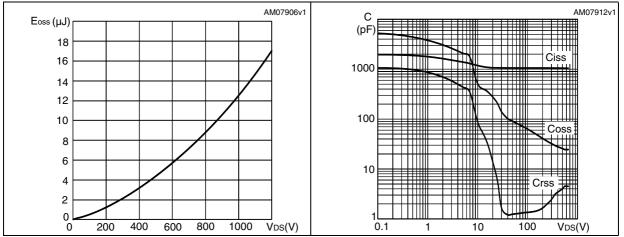


Figure 12. Output capacitance stored energy Figure 13. Capacitance variations



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Maximum avalanche energy vs

100

80

120 140 TJ(°C)

AM07904v1

temperature

Eas

(mJ)

180 160

140 120 100

> 80 60

> 40 20

> > 0

0

20 40

60

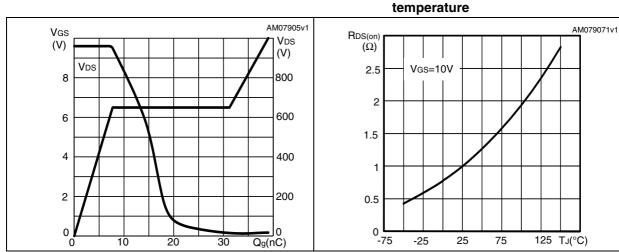




Figure 16. Normalized gate threshold voltage Figure 17. vs temperature

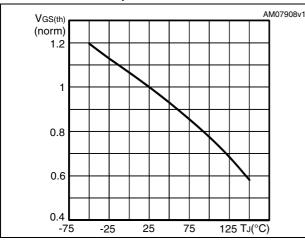
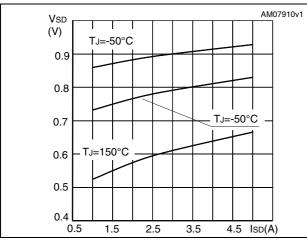


Figure 18. Source-drain diode forward characteristics



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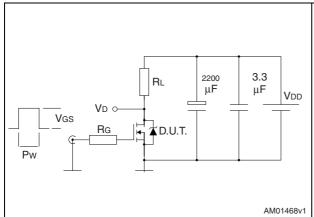
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## 3 Test circuits

Figure 19. Switching times test circuit for resistive load



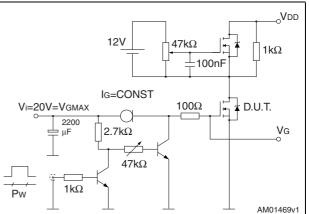
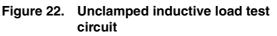
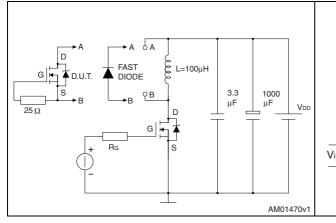


Figure 20. Gate charge test circuit

Figure 21. Test circuit for inductive load switching and diode recovery times





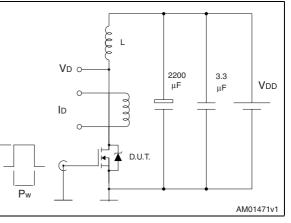
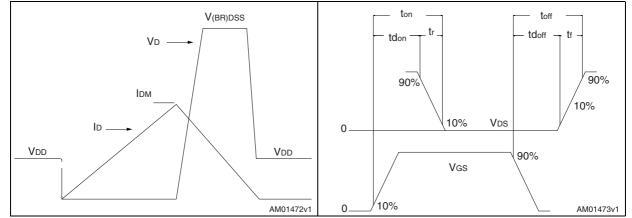




Figure 24. Switching time waveform





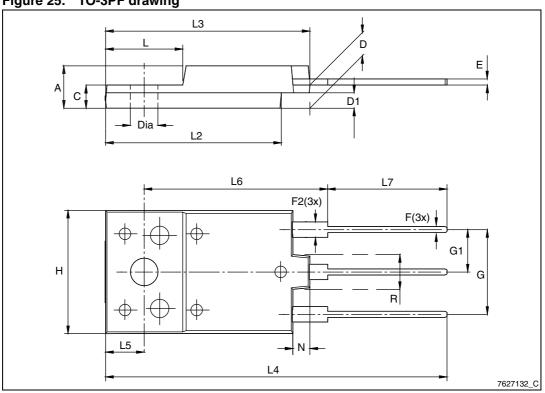
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Dim	mm			
Dim.	Min.	Тур.	Max.	
А	5.30		5.70	
С	2.80		3.20	
D	3.10		3.50	
D1	1.80		2.20	
E	0.80		1.10	
F	0.65		0.95	
F2	1.80		2.20	
G	10.30		11.50	
G1		5.45		
Н	15.30		15.70	
L	9.80	10	10.20	
L2	22.80		23.20	
L3	26.30		26.70	
L4	43.20		44.40	
L5	4.30		4.70	
L6	24.30		24.70	
L7	14.60		15	
Ν	1.80		2.20	
R	3.80		4.20	
Dia	3.40		3.80	

Table 9. TO-3PF mechanical data





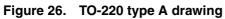
### Figure 25. TO-3PF drawing

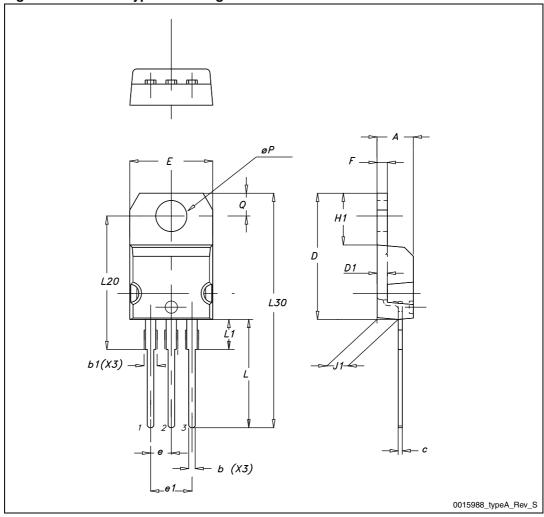


Dim	mm			
Dim. —	Min.	Тур.	Max.	
A	4.40		4.60	
b	0.61		0.88	
b1	1.14		1.70	
с	0.48		0.70	
D	15.25		15.75	
D1		1.27		
E	10		10.40	
е	2.40		2.70	
e1	4.95		5.15	
F	1.23		1.32	
H1	6.20		6.60	
J1	2.40		2.72	
L	13		14	
L1	3.50		3.93	
L20		16.40		
L30		28.90		
ØР	3.75		3.85	
Q	2.65		2.95	

Table 10. TO-220 type A mechanical data









Dim.	mm.			
Dini.	Min.	Тур.	Max.	
А	4.85		5.15	
A1	2.20		2.60	
b	1.0		1.40	
b1	2.0		2.40	
b2	3.0		3.40	
с	0.40		0.80	
D	19.85		20.15	
E	15.45		15.75	
е	5.30	5.45	5.60	
L	14.20		14.80	
L1	3.70		4.30	
L2		18.50		
ØP	3.55		3.65	
ØR	4.50		5.50	
S	5.30	5.50	5.70	

Table 11.TO-247 mechanical data



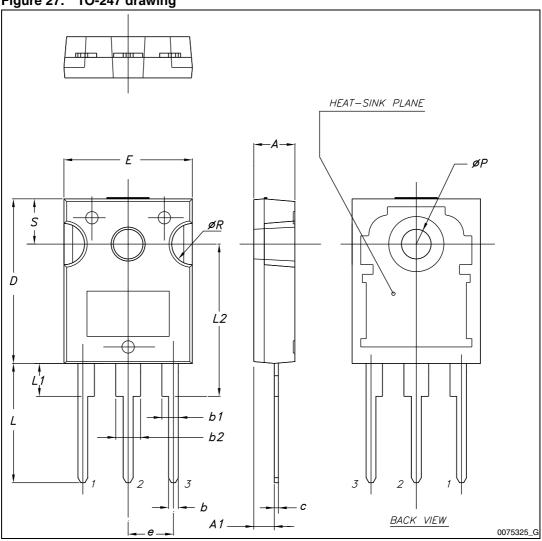


Figure 27. TO-247 drawing



# 5 Revision history

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Date	Revision	Changes
15-Apr-2009	1	First release.
02-Aug-2010	2	Document status promoted from preliminary data to datasheet. Inserted Section 2.1: Electrical characteristics (curves).
14-Nov-2012 3		<i>Figure 13: Capacitance variations</i> and <i>Figure 14: Gate charge vs gate-source voltage</i> have been corrected. Minor text changes.



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